

HM12N20D-VB Datasheet

N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	200					
$R_{DS(on)}$ Typ. (Ω) at V_{GS} = 10 V	0.038					
$R_{DS(on)}$ Typ. (Ω) at V_{GS} = 7.5 V	0.043					
Q _g typ. (nC)	20					
I _D (A)	30					
Configuration	Single					



FEATURES

- Thunder technology optimizes balance of $\mathsf{R}_{DS(on)},\,\mathsf{Q}_g,\,\mathsf{Q}_{sw}$ and Q_{oss}
- 100 % R_q and UIS tested

APPLICATIONS

- Fixed telecom
- DC/DC converter
- Primary and secondary side switch
- Synchronous rectification
- LED lighting
- Power supplies
- Class D amplifier



n D

N-Channel MOSFET

PARAMETER Drain-source voltage Gate-source voltage		SYMBOL	LIMIT	UNIT	
		V _{DS}	200	N	
		V _{GS}	± 20	V	
	T _C = 25 °C		30		
Continuous durin current (T. 150 °C)	T _C = 70 °C		23		
Continuous drain current (T _J = 150 °C)	T _A = 25 °C		7.6 ^{b, c}		
	T _A = 70 °C	1	5.9 ^{b, c}		
Pulsed drain current (t = 100 µs)		I _{DM}	70	A	
Continuous source-drain diode current	T _C = 25 °C		30		
	T _A = 25 °C	I _S	5.6 ^{b, c}		
Single pulse avalanche current		I _{AS}	30		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	45	mJ	
	T _C = 25 °C		104		
NAL THE REPORT OF A DECEMBER OF	T _C = 70 °C		66.6		
Maximum power dissipation	T _A = 25 °C	P _D	6.25 ^{b, c}	W	
	T _A = 70 °C	1 -	4 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150		
Soldering recommendations (peak tempera		260	°C		

THERMAL RESISTANCE RATINGS								
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum junction-to-ambient ^b	t ≤ 10 s	R _{thJA}	15	20	°C/W			
Maximum junction-to-case (drain)	Steady state	R _{thJC}	0.9	1.2	C/ VV			

Notes

a. Package limited.b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. The DFN5x 6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 54 °C/W.

g. $T_C = 25 \ ^{\circ}C.$

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static			I	•		1
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	200	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	173	-	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-7.1	-	mV/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2.0		4.0	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$	-	-	100	nA
7		V _{DS} = 200 V, V _{GS} = 0 V	-	-	1	μA
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 70 ^{\circ}\text{C}$	-	-	15	
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10$ V, V_{GS} =10 V	30	-	-	А
	_	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 10 \text{ A}$	-	0.038	-	Ω
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 10 A	-	0.043	-	
Forward transconductance ^a	g _{fs}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 10 \text{ A}$	-	27	-	S
Dynamic ^b						
Input capacitance	C _{iss}		-	1380	-	pF
Output capacitance	C _{oss}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$	-	142	-	
Reverse transfer capacitance	C _{rss}		-	11	-	
	Qg	$V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	-	25	38	nC
Total gate charge			-	20	30	
Gate-source charge	Q _{gs}	V_{DS} = 100 V, V_{GS} = 7.5 V, I_{D} = 10 A	-	6.4	-	
Gate-drain charge	Q _{gd}		-	6.8	-	
Output charge	Q _{oss}	V _{DS} = 100 V, V _{GS} = 0 V	-	52	-	
Gate resistance	Rg	f = 1 MHz	0.6	2.1	4	Ω
Turn-on delay time	t _{d(on)}		-	9	18	_
Rise time	t _r	$V_{DD} = 100 \text{ V}, \text{ R}_{\text{I}} = 10 \Omega, \text{ I}_{\text{D}} \cong 10 \text{ A},$	-	20	40	
Turn-off delay time	t _{d(off)}	$V_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$	-	20	40	
Fall time	t _f		-	24	48	
Turn-on delay time	t _{d(on)}		-	11	22	- ns -
Rise time	t _r	V_{DD} = 100 V, R_L = 10 Ω , $I_D \cong$ 10 A,	-	27	54	
Turn-off delay time	t _{d(off)}	$V_{\text{GEN}} = 7.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$	-	18	36	
Fall time	t _f		-	24	48	
Drain-Source Body Diode Characteristi	cs			•		
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	35.4	•
Pulse diode forward current	I _{SM}		-	-	80	A
Body diode voltage	V _{SD}	$I_{S} = 5 \text{ A}, V_{GS} = 0 \text{ V}$	-	0.77	1.1	V
Body diode reverse recovery time	t _{rr}		-	100	200	ns
Body diode reverse recovery charge	Q _{rr}		-	400	800	nC
Reverse recovery fall time	ta	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^\circ\text{C}$	-	80	-	
Reverse recovery rise time	t _b			20	-	ns

Notes

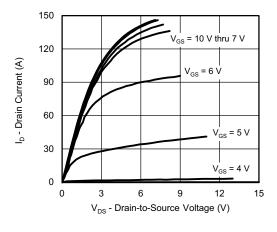
a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

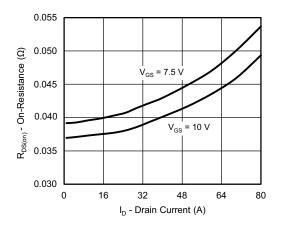
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

semi

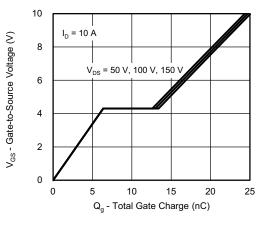




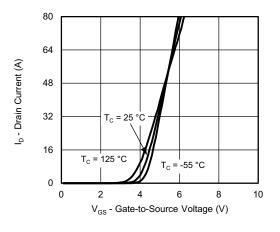
Output Characteristics



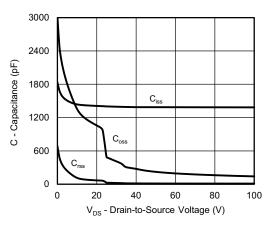
On-Resistance vs. Drain Current and Gate Voltage



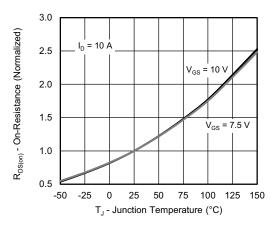
Gate Charge



Transfer Characteristics

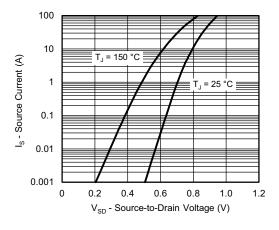


Capacitance

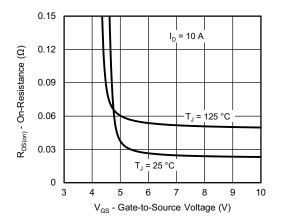


On-Resistance vs. Junction Temperature

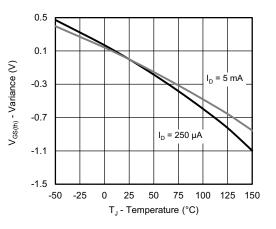




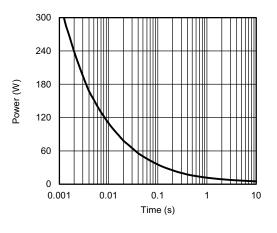
Source-Drain Diode Forward Voltage



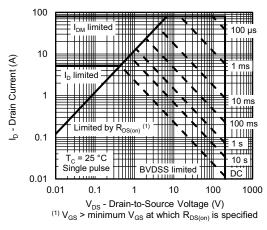
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

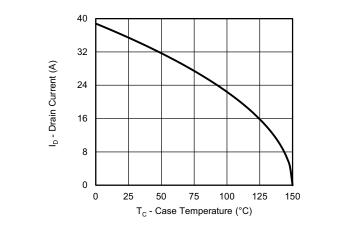


Single Pulse Power, Junction-to-Ambient

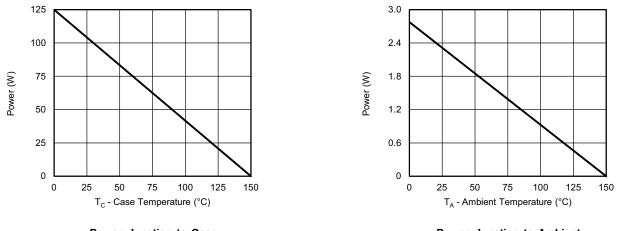


Safe Operating Area, Junction-to-Ambient





Current Derating ^a



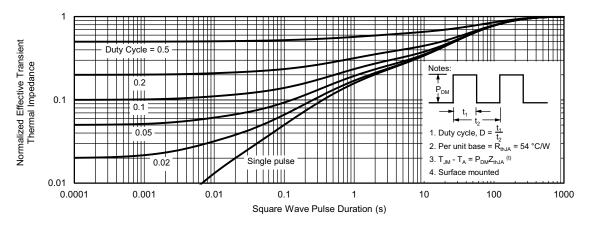
Power, Junction-to-Case

Power, Junction-to-Ambient

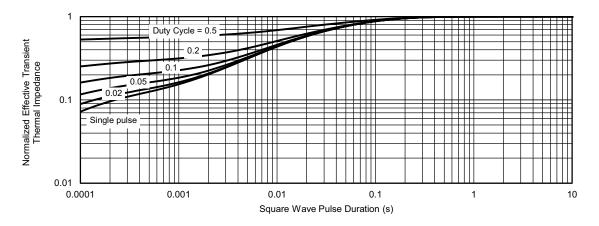
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





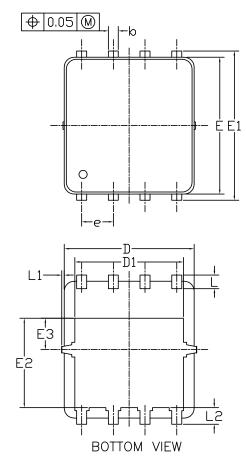
Normalized Thermal Transient Impedance, Junction-to-Ambient

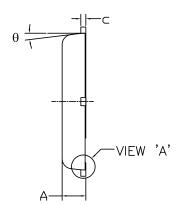


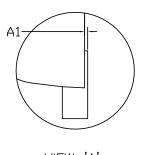
Normalized Thermal Transient Impedance, Junction-to-Case



DFN5x6_8L_EP1_P PACKAGE OUTLIN

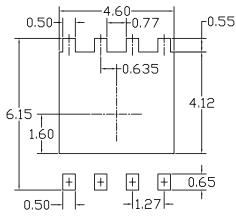






<u>VIEW 'A'</u> (SCALE 5:1)

RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
51 MIDOLS	MIN	NOM	MAX	MIN	NOM	MAX
А	0.85	0.95	1.00	0.033	0.037	0.039
A1	0.00		0.05	0.000		0.002
b	0.30	0.40	0.50	0.012	0.016	0.020
c	0.15	0.20	0.25	0.006	0.008	0.010
D	5.10	5.20	5.30	0.201	0.205	0.209
D1	4.25	4.35	4.45	0.167	0.171	0.175
E	5.45	5.55	5.65	0.215	0.219	0.222
E1	5.95	6.05	6.15	0.234	0.238	0.242
E2	3.525	3.625	3.725	0.139	0.143	0.147
E3	1.175	1.275	1.375	0.046	0.050	0.054
e	1.27 BSC			0.050 BSC		
L	0.45	0.55	0.65	0.018	0.022	0.026
L1	0		0.15	0		0.006
L2	0.68 REF			0.027 REF		
θ	0°		10°	0°		10°

NOTE

1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.

UNIT: mm

MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.

2. CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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